Unit: mm

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSIII)

2SK2719

Chopper Regulator, DC-DC Converter and Motor Drive Applications

• Low drain-source ON resistance: RDS (ON) = 3.7Ω (typ.)

• High forward transfer admittance: $|Y_{fs}| = 2.6 \text{ S (typ.)}$

• Low leakage current: $I_{DSS} = 100 \,\mu\text{A} \,(\text{max}) \,(V_{DS} = 720 \,\text{V})$

• Enhancement mode: $V_{th} = 2.0 \sim 4.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	900	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V_{DGR}	900	V	
Gate-source voltage		V _{GSS}	±30	V	
Drain current	DC (Note 1)	I _D	3	А	
	Pulse (Note 1)	I _{DP}	9		
Drain power dissipation (Tc = 25°C)		PD	125	W	
Single pulse avalanche energy (Note 2)		E _{AS}	295	mJ	
Avalanche current		I _{AR}	3	Α	
Repetitive avalanche energy (Note 3)		E _{AR}	12.5	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

2-16C1B

Weight: 4.6 g (typ.)

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Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	1.0	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	50.0	°C/W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: $V_{DD} = 25$ V, $T_{ch} = 25^{\circ}C$ (initial), L = 58 μH , $R_{G} = 25$ Ω , $I_{AR} = 45$ A

Note 3: Repetitive rating: pulse width limited by maximum junction temperature

This transistor is an electrostatic-sensitive device. Please handle with caution.



Electrical Characteristics (Ta = 25°C)

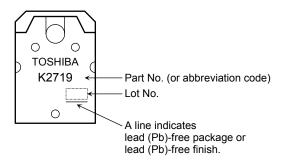
Chara	acteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±10	μА
Gate-source brea	akdown voltage	V (BR) GSS	$I_G = \pm 10 \ \mu A, \ V_{DS} = 0 \ V$	±30	_	_	V
Drain cut-off curre	ent	I _{DSS}	V _{DS} = 720 V, V _{GS} = 0 V	_	_	100	μА
Drain-source brea	akdown voltage	V (BR) DSS	$I_D = 10$ mA, $V_{GS} = 0$ V	900	_	_	V
Gate threshold voltage		V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	V
Drain-source ON	resistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 1.5 A	_	3.7	4.3	Ω
Forward transfer	sfer admittance $ Y_{fS} $ $V_{DS} = 20 \text{ V}, I_D = 1.5 \text{ A}$		V _{DS} = 20 V, I _D = 1.5 A	0.65	2.6	_	S
Input capacitance	9	C _{iss}			750	_	pF
Reverse transfer capacitance		C _{rss}	V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz	_	10	_	pF
Output capacitance		Coss		_	70	_	pF
Switching time	Rise time	t _r	V_{GS} V_{GS} $V_{DD} \simeq 200 \text{ V}$ Duty $\leq 1\%$, $t_W = 10 \mu\text{s}$	_	15	_	
	Turn-on time	t _{on}			55	_	ne
	Fall time	t _f		_	30	_	ns
	Turn-off time	t _{off}			110	_	
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}$	_	25	_	nC
Gate-source charge		Q _{gs}		_	13	_	nC
Gate-drain ("miller") charge		Q _{gd}			12	_	nC

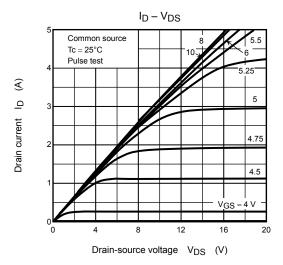
Source-Drain Diode Ratings and Characteristics (Ta = 25°C)

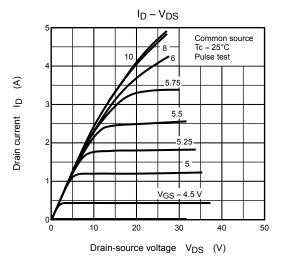
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	3	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_		_	9	Α
Diode forward voltage	V _{DSF}	$I_{DR} = 3 A$, $V_{GS} = 0 V$		_	-1.9	V
Reverse recovery time	t _{rr}	$I_{DR} = 3 A$, $V_{GS} = 0 V$		1100	_	ns
Reverse recovery charge	Q _{rr}	dI _{DR} /dt = 100 A/μs		7.5	_	μС

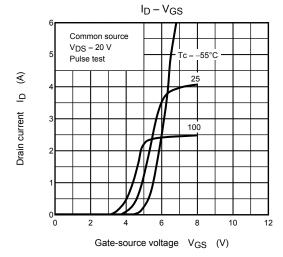
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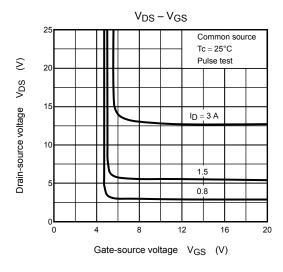
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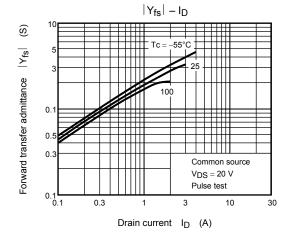


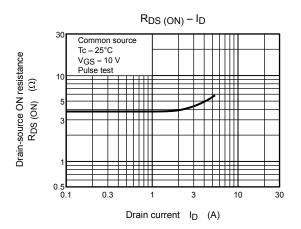




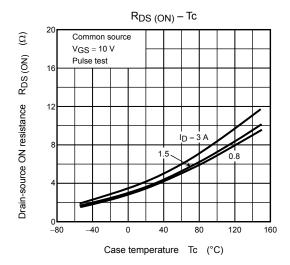


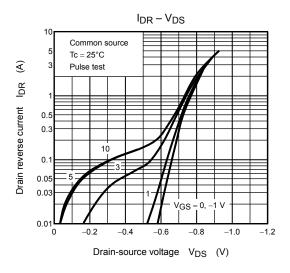


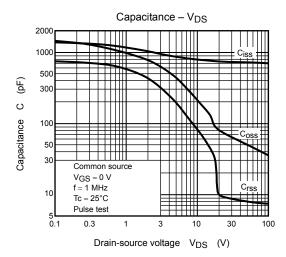


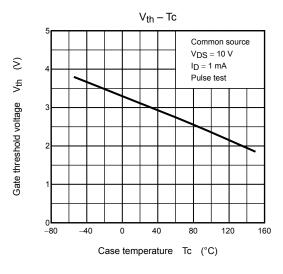


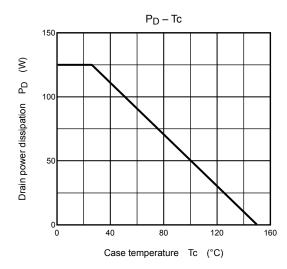
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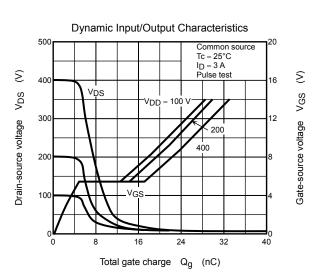


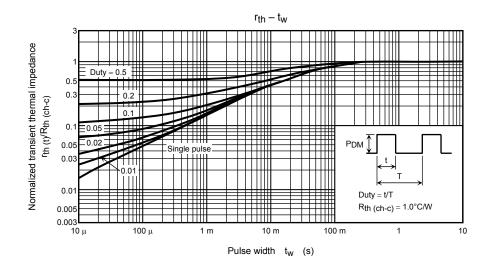


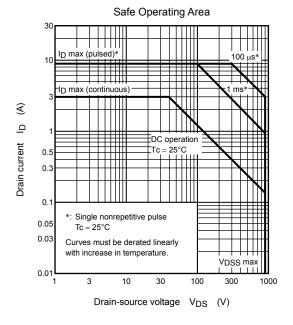


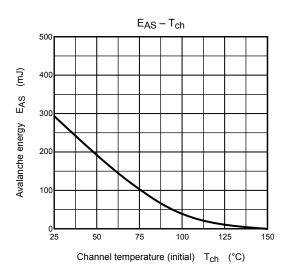


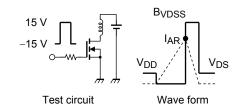












$$R_G = 25~\Omega$$

$$V_{DD} = 90~V,~L = 60~mH$$

$$E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$$

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20070701-EN

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